

64-Channel Serial-to-Parallel Converter with P-Channel Open Drain Controllable Output Current

Features

- 5V CMOS Logic
- Up to -85V Output Voltage
- Output Current Source Control
- 16 MHz Equivalent Data Rate
- Latched Data Outputs
- Forward and Reverse Shifting Options (DIR pin)
- Diode to V_{DD} allows Efficient Power Recovery

Applications

- Plasma Panel Driver
- Display Driver
- Print Head Driver
- Relay Driver
- Microelectromechanical Systems Applications

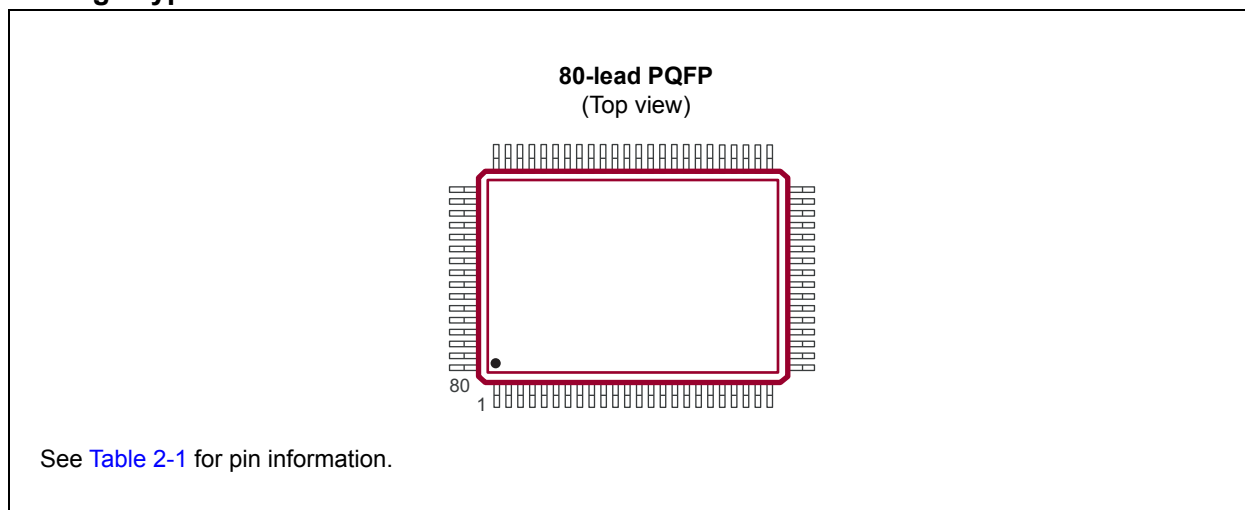
General Description

The HV57009 is a low-voltage to high-voltage serial-to-parallel converter with P-channel open drain outputs. This device has been designed as a driver for plasma panels.

The device has two parallel 32-bit Shift registers, permitting data rates twice the speed of one in a single clock cycle. There are also 64 latches and control logic to perform the blanking of the outputs. HV_{OUT1} is connected to the first stage of the first Shift register through the blanking logic. Data is shifted through the Shift registers on the logic low-to-high transition of the clock. The DIR pin causes counter-clockwise shifting when connected to V_{SS} and clockwise shifting when connected to V_{DD} . A data output buffer is provided for cascading devices. This output reflects the current status of the last bit of the Shift register, HV_{OUT64} . The operation of the Shift register is not affected by the latch enable (\overline{LE}) and the blanking (\overline{BL}) inputs. Data transfer from the Shift registers to the latches occurs when the \overline{LE} input is high. The data in the latches is stored when \overline{LE} is low.

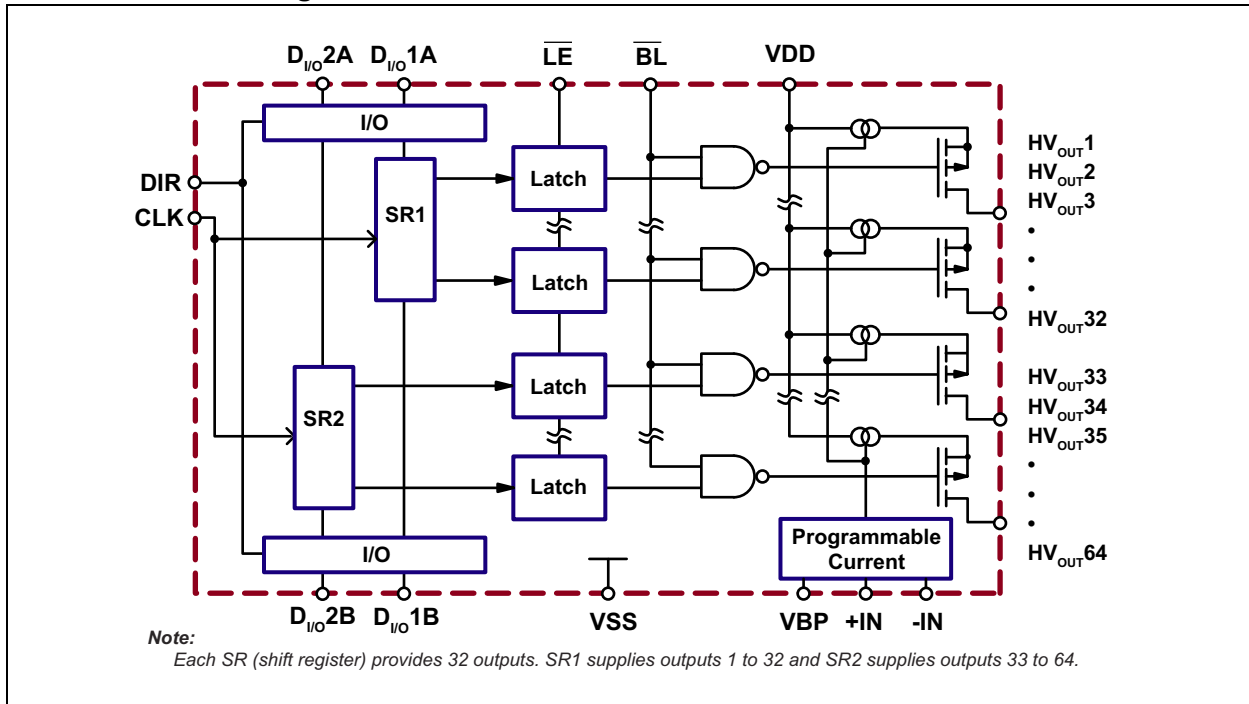
The HV57009 has 64 channels of output constant-current sourcing capability. They are adjustable from 0.1 mA to 2 mA through one external resistor or a current source.

Package Type

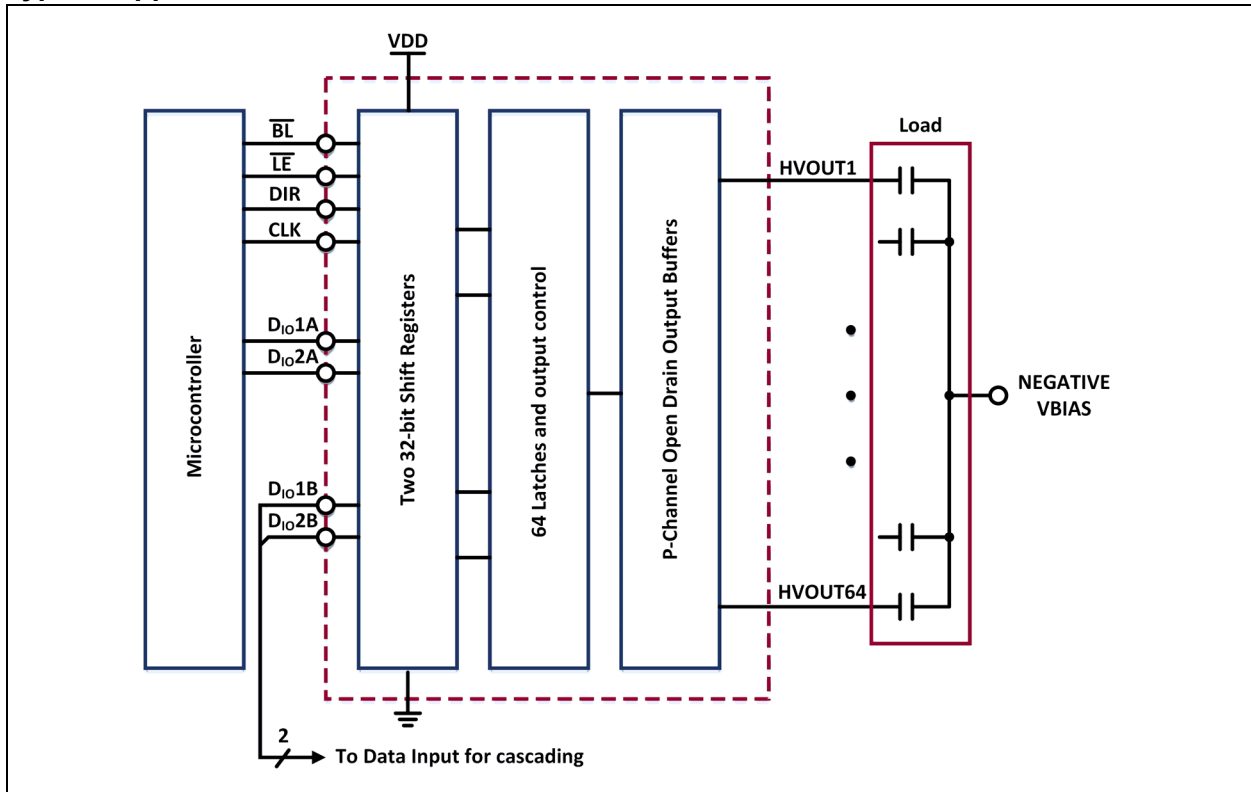


HV57009

Functional Block Diagram



Typical Application Circuit



HV57009

1.0 ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings†

Supply Voltage, V_{DD} (Note 1)	-0.5V to +7.5V
Output Voltage, V_{NN} (Note 1)	$V_{DD} + 0.5V$ to $-95V$
Logic Input Levels (Note 1)	$-0.3V$ to $V_{DD} + 0.3V$
Ground Current (Note 2)	1.5A
Operating Ambient Temperature, T_A	$-40^{\circ}C$ to $+85^{\circ}C$
Storage Temperature, T_S	$-65^{\circ}C$ to $+150^{\circ}C$
Continuous Total Power Dissipation:	
80-lead PQFP (Note 3)	1200 mW

† **Notice:** Stresses above those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. This is a stress rating only, and functional operation of the device at those or any other conditions above those indicated in the operational sections of this specification is not intended. Exposure to maximum rating conditions for extended periods may affect device reliability.

- Note 1:** All voltages are referenced to V_{SS} .
Note 2: Duty cycle is limited by the total power dissipated in the package.
Note 3: For operations above $25^{\circ}C$ ambient, derate linearly to the maximum operating temperature at $20\text{ mW}/^{\circ}C$.

RECOMMENDED OPERATING CONDITIONS

Parameter	Sym.	Min.	Typ.	Max.	Unit	Conditions
Logic Supply Voltage	V_{DD}	4.5	—	5.5	V	
High-Voltage Output Voltage	HV_{OUT}	-85	—	V_{DD}	V	
High-Level Input Voltage	V_{IH}	$V_{DD} - 1.2V$	—	V_{DD}	V	
Low-Level Input Voltage	V_{IL}	0	—	1.2	V	
Clock Frequency per Register	f_{CLK}	DC	—	8	MHz	
			—	4.5	MHz	
Operating Ambient Temperature	T_A	-40	—	+85	$^{\circ}C$	

DC ELECTRICAL CHARACTERISTICS

Electrical Specifications: All voltages are referenced to V_{SS} , $V_{SS} = 0$, and $T_A = 25^\circ\text{C}$. Current going out of the chip is considered negative.

Parameter	Sym.	Min.	Typ.	Max.	Unit	Conditions	
V_{DD} Supply Current	I_{DD}	—	—	15	mA	$V_{DD} = V_{DD}$ maximum, $f_{CLK} = 8$ MHz	
High-Voltage Supply Current	I_{NN}	—	—	-10	μA	Outputs off, $HV_{OUT} = -85\text{V}$ (total of all outputs)	
Quiescent V_{DD} Supply Current	I_{DDQ}	—	—	100	μA	All inputs = V_{DD} , except $+IN = V_{SS} = \text{GND}$	
High-Level Output	Data Out	V_{OH}	$V_{DD}-0.5\text{V}$	—	—	V	$I_O = -100 \mu\text{A}$
	HV_{OUT}		+1	—	V_{DD}	V	$I_O = -2 \text{ mA}$
Low-Level Output	Data Out	V_{OL}	—	—	+0.5	V	$I_O = 100 \mu\text{A}$
High-Level Logic Input Current	I_{IH}	—	—	1	μA	$V_{IH} = V_{DD}$	
Low-Level Logic Input Current	I_{IL}	—	—	-1	μA	$V_{IL} = 0\text{V}$	
High-Output Source Current	I_{CS}	—	—	-2	mA	$V_{REF} = 2\text{V}$, $R_{EXT} = 1 \text{ k}\Omega$, See Figure 3-3 and Figure 3-4 .	
		-0.1	—	—	mA	$V_{REF} = 0.1\text{V}$, $R_{EXT} = 1 \text{ k}\Omega$, See Figure 3-3 and Figure 3-4 .	
High-Voltage Output Source Current for $I_{REF} = 2 \text{ mA}$	ΔI_{CS}	—	—	10	%	$V_{REF} = 2\text{V}$, $R_{EXT} = 1 \text{ k}\Omega$,	

AC ELECTRICAL CHARACTERISTICS

Electrical Specifications: Logic signal inputs and data inputs have t_r , $t_f \leq 5 \text{ ns}$ (10% and 90% points) for measurements.

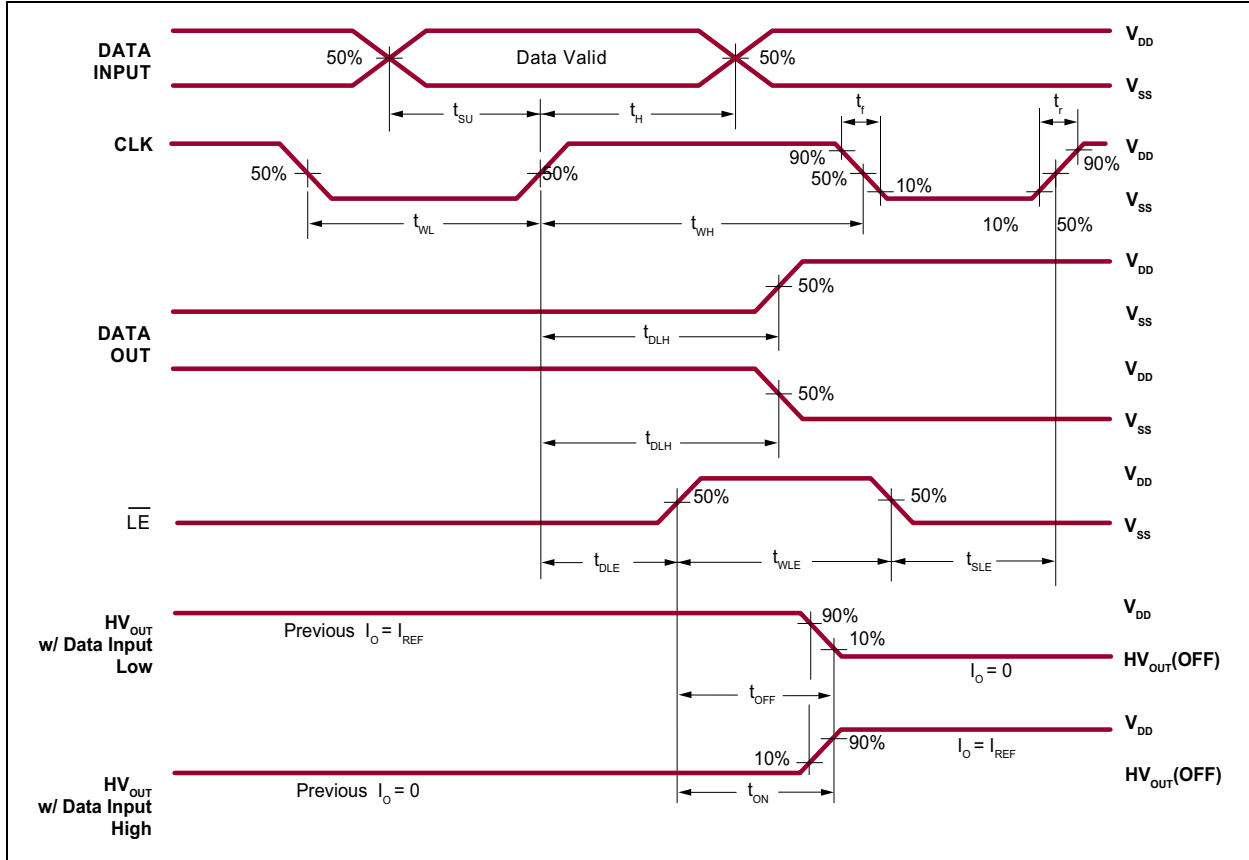
Parameter	Sym.	Min.	Typ.	Max.	Unit	Conditions
Clock Frequency	f_{CLK}	DC	—	8	MHz	Per register
			—	4.5	MHz	When cascading devices
Clock Width High or Low	t_{WL} , t_{WH}	62	—	—	ns	
Data Set-Up Time before Clock Rises	t_{SU}	20	—	—	ns	
Data Hold Time after Clock Rises	t_H	15	—	—	ns	
Time from Latch Enable to HV_{OUT}	t_{ON} , t_{OFF}	—	—	500	ns	$C_L = 15 \text{ pF}$
Latch Enable Pulse Width	t_{WLE}	25	—	—	ns	
Delay Time Clock to Latch Enable Low to High	t_{DLE}	45	—	—	ns	
Latch Enable Set-Up Time before Clock Rises	t_{SLE}	0	—	—	ns	
Delay Time Clock to Data Low to High	t_{DLH}	—	—	150	ns	$C_L = 15 \text{ pF}$
Delay Time Clock to Data High to Low	t_{DHL}	—	—	150	ns	$C_L = 15 \text{ pF}$
Maximum Allowable Clock Rise and Fall Time (10% and 90% Points)	t_r , t_f	—	—	100	ns	

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TEMPERATURE SPECIFICATIONS

Parameter	Sym.	Min.	Typ.	Max.	Unit	Conditions
TEMPERATURE RANGE						
Operating Ambient Temperature	T_A	-40	—	+85	°C	
Storage Temperature	T_S	-65	—	+150	°C	
PACKAGE THERMAL RESISTANCE						
80-lead PQFP	θ_{JA}	—	37	—	°C/W	

Timing Waveforms



2.0 PIN DESCRIPTION

The details on the pins of HV57009 are listed on [Table 2-1](#). Refer to [Package Type](#) for the location of pins.

TABLE 2-1: PIN FUNCTION TABLE

Pin Number	Pin Name	Description
1	HVOUT24	High-voltage output
2	HVOUT23	High-voltage output
3	HVOUT22	High-voltage output
4	HVOUT21	High-voltage output
5	HVOUT20	High-voltage output
6	HVOUT19	High-voltage output
7	HVOUT18	High-voltage output
8	HVOUT17	High-voltage output
9	HVOUT16	High-voltage output
10	HVOUT15	High-voltage output
11	HVOUT14	High-voltage output
12	HVOUT13	High-voltage output
13	HVOUT12	High-voltage output
14	HVOUT11	High-voltage output
15	HVOUT10	High-voltage output
16	HVOUT9	High-voltage output
17	HVOUT8	High-voltage output
18	HVOUT7	High-voltage output
19	HVOUT6	High-voltage output
20	HVOUT5	High-voltage output
21	HVOUT4	High-voltage output
22	HVOUT3	High-voltage output
23	HVOUT2	High-voltage output
24	HVOUT1	High-voltage output
25	DI/O1A	Data Input/Output 1A pin
26	DI/O2A	Data Input/Output 2A pin
27	NC	No connection
28	NC	No connection
29	\overline{LE}	Latch enable pin
30	CLK	Clock pin
31	\overline{BL}	Blanking pin
32	VSS	Reference voltage (usually ground)
33	DIR	Direction pin (See Note 1 .)
34	VDD	Logic supply voltage (See Note 2 .)

Note 1: Pin designation for DIR = V_{DD} .

2: 0.1 μ F capacitor is needed between VDD and VBP (pin 40) for better output current stability and to prevent transient cross-coupling between outputs. See [Figure 3-3](#) and [Figure 3-4](#).

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TABLE 2-1: PIN FUNCTION TABLE (CONTINUED)

Pin Number	Pin Name	Description
35	-IN	-IN input pin
36	DI/O2B	Data Input/Output 2B pin
37	DI/O1B	Data Input/Output 1B pin
38	NC	No connection
39	+IN	+IN input pin
40	VBP	Bias control voltage (See Note 2 .)
41	HVOUT64	High-voltage output
42	HVOUT63	High-voltage output
43	HVOUT62	High-voltage output
44	HVOUT61	High-voltage output
45	HVOUT60	High-voltage output
46	HVOUT59	High-voltage output
47	HVOUT58	High-voltage output
48	HVOUT57	High-voltage output
49	HVOUT56	High-voltage output
50	HVOUT55	High-voltage output
51	HVOUT54	High-voltage output
52	HVOUT53	High-voltage output
53	HVOUT52	High-voltage output
54	HVOUT51	High-voltage output
55	HVOUT50	High-voltage output
56	HVOUT49	High-voltage output
57	HVOUT48	High-voltage output
58	HVOUT47	High-voltage output
59	HVOUT46	High-voltage output
60	HVOUT45	High-voltage output
61	HVOUT44	High-voltage output
62	HVOUT43	High-voltage output
63	HVOUT42	High-voltage output
64	HVOUT41	High-voltage output
65	HVOUT40	High-voltage output
66	HVOUT39	High-voltage output
67	HVOUT38	High-voltage output
68	HVOUT37	High-voltage output
69	HVOUT36	High-voltage output
70	HVOUT35	High-voltage output
71	HVOUT34	High-voltage output
72	HVOUT33	High-voltage output
73	HVOUT32	High-voltage output

Note 1: Pin designation for DIR = V_{DD} .

2: 0.1 μ F capacitor is needed between VDD and VBP (pin 40) for better output current stability and to prevent transient cross-coupling between outputs. See [Figure 3-3](#) and [Figure 3-4](#).

TABLE 2-1: PIN FUNCTION TABLE (CONTINUED)

Pin Number	Pin Name	Description
74	HVOUT31	High-voltage output
75	HVOUT30	High-voltage output
76	HVOUT29	High-voltage output
77	HVOUT28	High-voltage output
78	HVOUT27	High-voltage output
79	HVOUT26	High-voltage output
80	HVOUT25	High-voltage output

Note 1: Pin designation for DIR = V_{DD} .

2: 0.1 μ F capacitor is needed between VDD and VBP (pin 40) for better output current stability and to prevent transient cross-coupling between outputs. See [Figure 3-3](#) and [Figure 3-4](#).

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3.0 FUNCTIONAL DESCRIPTION

Follow the steps in [Table 3-1](#) to power up and power down the HV57009.

TABLE 3-1: POWER-UP AND POWER-DOWN SEQUENCE

Power-up		Power-down	
Step	Description	Step	Description
1	Connect ground.	1	Remove V_{PP} .
2	Apply V_{DD} .	2	Remove all inputs.
3	Set all inputs (Data, CLK, Enable, etc.) to a known state.	3	Remove V_{DD} .
4	Apply V_{PP} .	4	Disconnect ground.

TABLE 3-2: TRUTH FUNCTION TABLE

Function	Inputs						Outputs	
	Data	CLK	\overline{LE}	\overline{BL}	DIR	Shift Register	High-voltage Output	Data Out
All O/P High	X	X	X	L	X	*	ON	*
Data Falls Through (Latches Transparent)	L	↑	H	H	X	L...L	ON	L
	H	↑	H	H	X	H...H	OFF	H
Data Stored in Latches	X	X	L	H	X	*	Inversion of stored data	*
I/O Relation	$D_{I/O1-2A}$	↑	H	H	H	$Q_N \rightarrow Q_{N+1}$	New ON or OFF	$D_{I/O1-2B}$
	$D_{I/O1-2A}$	↑	L	H	H	$Q_N \rightarrow Q_{N+1}$	Previous ON or OFF	$D_{I/O1-2B}$
	$D_{I/O1-2B}$	↑	L	H	L	$Q_N \rightarrow Q_{N-1}$	Previous ON or OFF	$D_{I/O1-2A}$
	$D_{I/O1-2B}$	↑	H	H	L	$Q_N \rightarrow Q_{N-1}$	New ON or OFF	$D_{I/O1-2A}$

Note: H = V_{DD} (Logic)/ V_{NN} (HV Outputs)

L = V_{SS}

↑ = Low-to-high transition

* = Dependent on the previous stage's state. See [Figure 3-2](#) for D_{IN} and D_{OUT} pin designation for clockwise and counter-clockwise shifts.

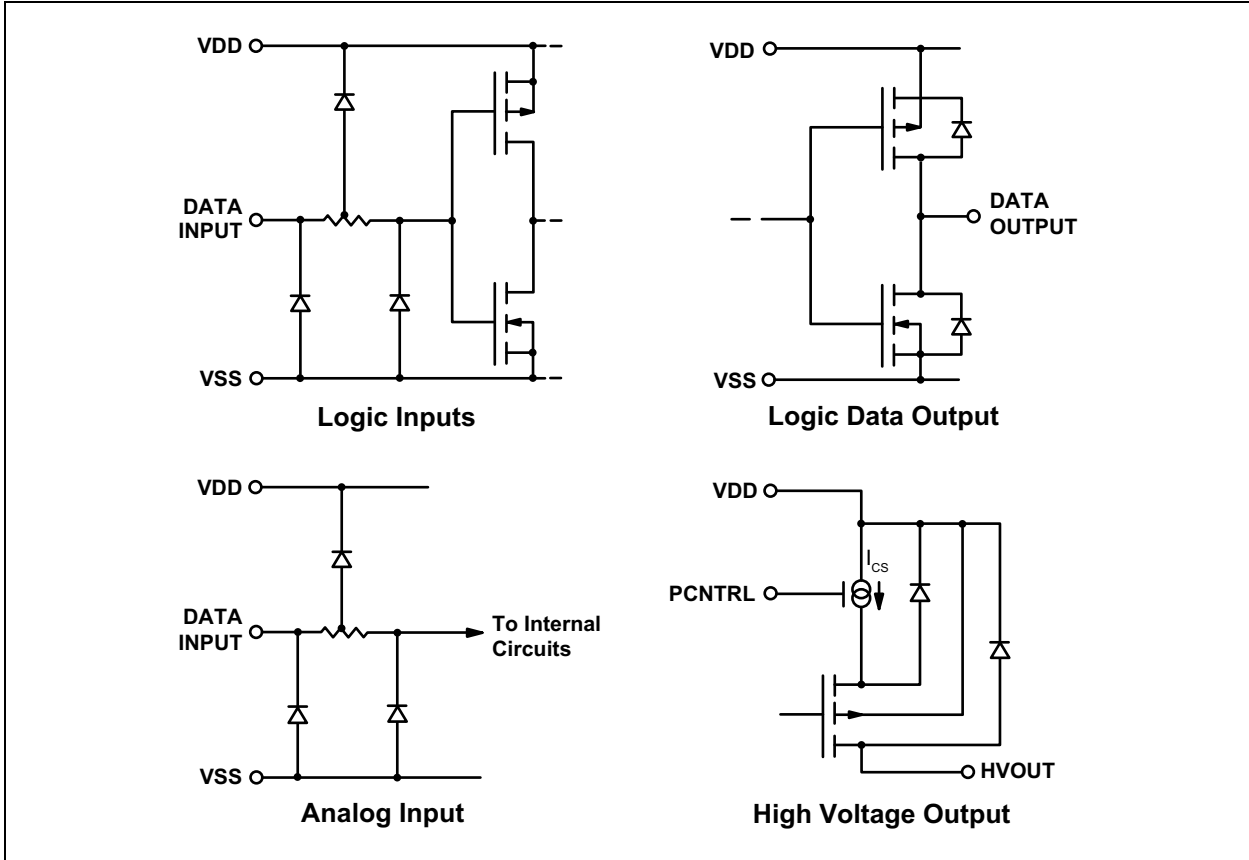


FIGURE 3-1: Input and Output Equivalent Circuits.

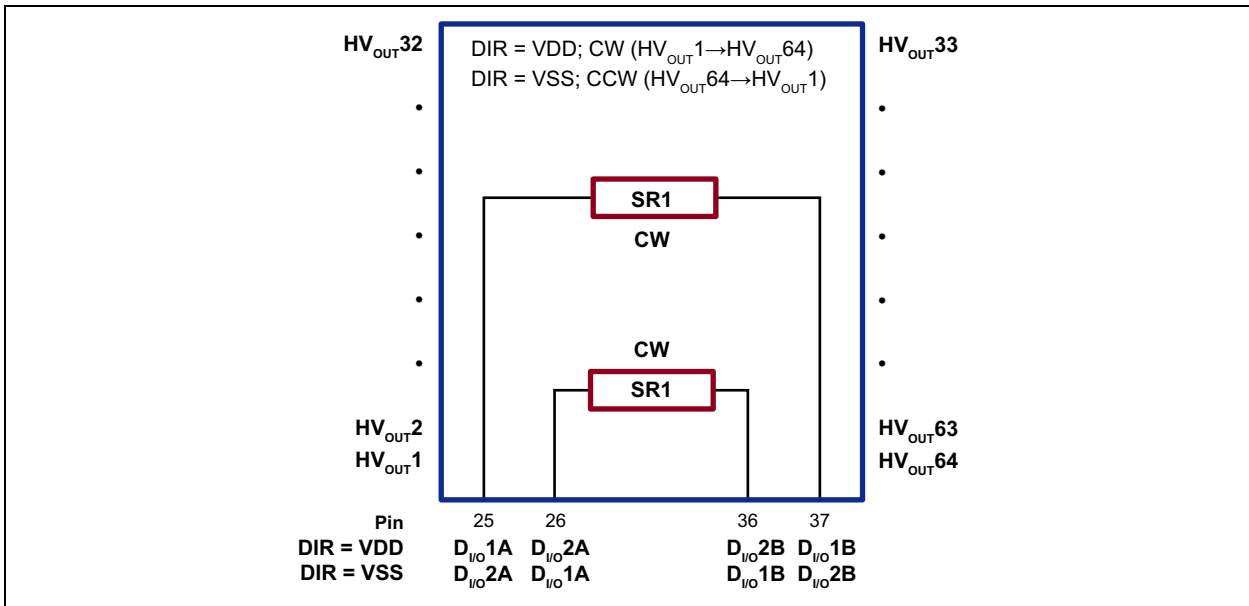


FIGURE 3-2: Shift Register Operation.

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3.1 Typical Current Programming Circuits

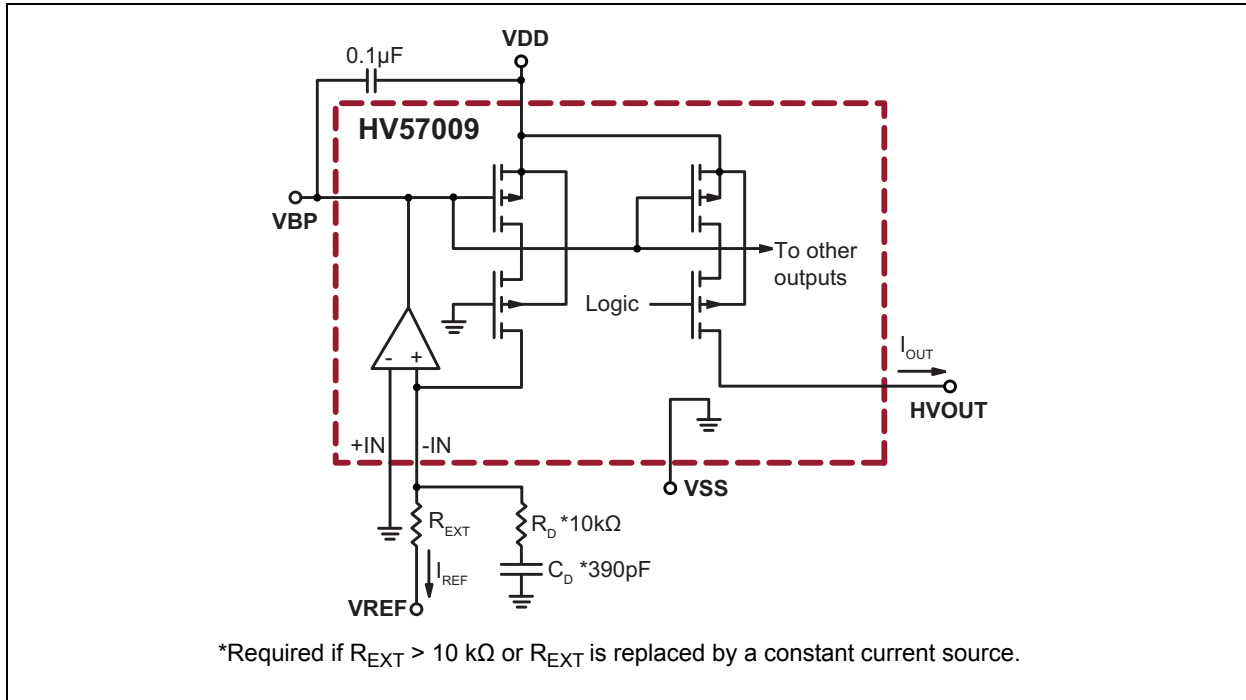


FIGURE 3-3: Negative Control Circuit.

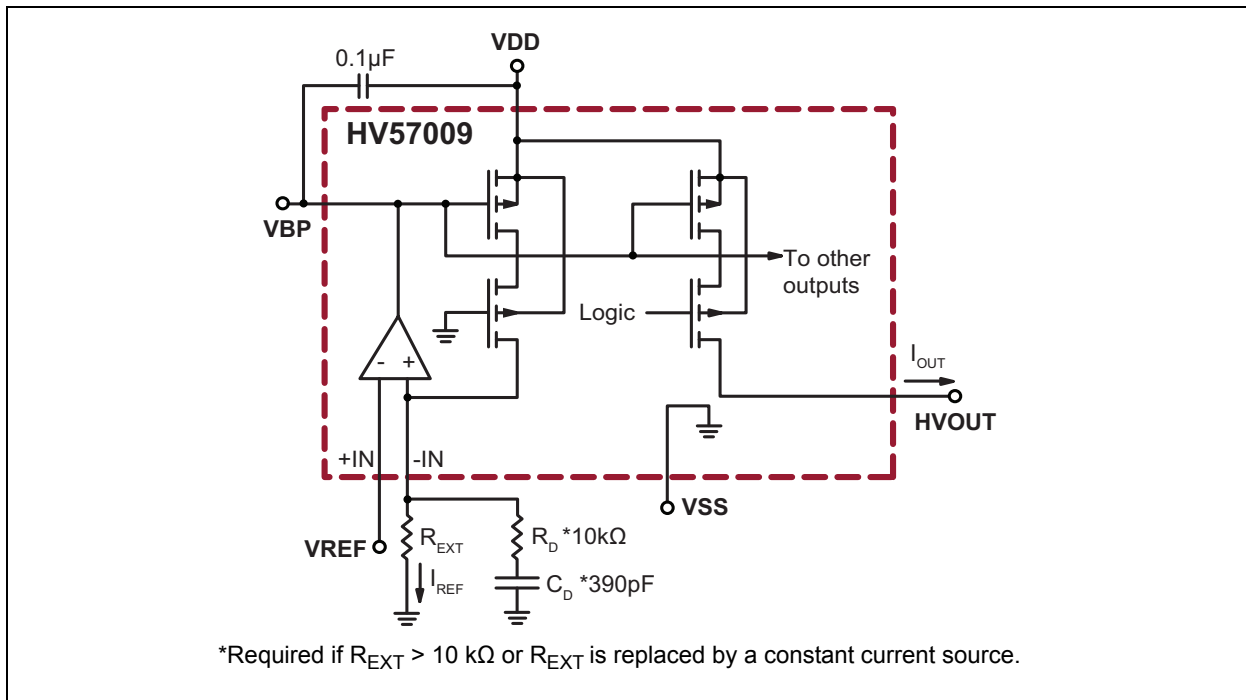


FIGURE 3-4: Positive Control Circuit.

Figure 3-3 and Figure 3-4 show the programming circuits to control the high-voltage output current limit. A reference current I_{REF} is set by the external resistor R_{EXT} and reference voltage V_{REF} . The current mirror formed by the matching transistors uses the reference current to cap the maximum allowed current at the high-voltage output. The relationship between I_{OUT} and I_{REF} are shown in Equation 3-1 and Equation 3-2.

EQUATION 3-1:

$$I_{OUT} = I_{REF} = |V_{REF}| / R_{EXT}$$

EQUATION 3-2:

If $I_{OUT} = 2 \text{ mA}$ and $V_{REF} = -5V \rightarrow R_{EXT} = 2.5 \text{ k}\Omega$
 If $I_{OUT} = 1 \text{ mA}$ and $R_{EXT} = 1 \text{ k}\Omega \rightarrow V_{REF} = -1V$

If $R_{EXT} > 10 \text{ k}\Omega$, add series network R_D and C_D to ground for stability as shown in Figure 3-3 and Figure 3-4.

This control method behaves linearly as long as the operational amplifier is not saturated. However, it requires a negative power source and needs to provide a current $I_{REF} = I_{OUT}$ for each HV57009 chip being controlled.

If $HV_{OUT} \geq +1V$, the HV_{OUT} cascade may no longer operate as a perfect current source, and the output current will diminish. This effect depends on the magnitude of the output current.

Given I_{OUT} and V_{REF} , the R_{EXT} can be calculated using Equation 3-3:

EQUATION 3-3:

$$R_{EXT} = V_{REF} / I_{REF} = V_{REF} / I_{OUT}$$

The intersection of a set of I_{OUT} and V_{REF} values can be located in Figure 3-5. The value picked for R_{EXT} must always be in the shaded area for linear operation. This control method has the advantage that V_{REF} is positive and draws leakage current only. If $R_{EXT} > 10 \text{ k}\Omega$, add series network R_D and C_D to ground for stability as shown in Figure 3-3 and Figure 3-4.

Note: Lower reference current, I_{REF} , results in higher distortion, ΔI_{CS} , on the output.

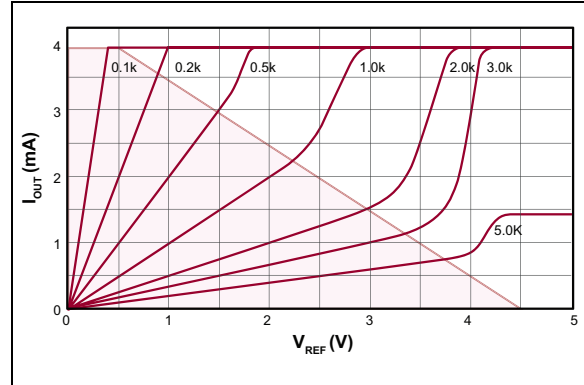
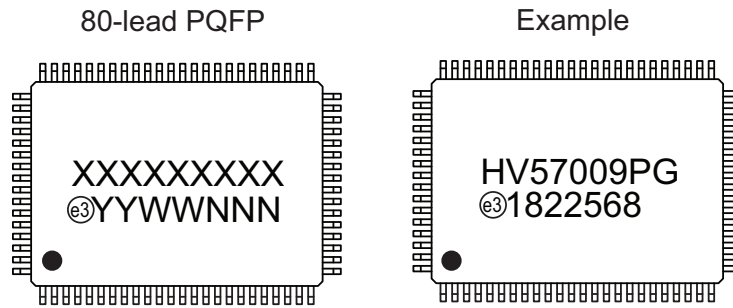


FIGURE 3-5: I_{OUT} vs. I_{REF}

HV57009

4.0 PACKAGE MARKING INFORMATION

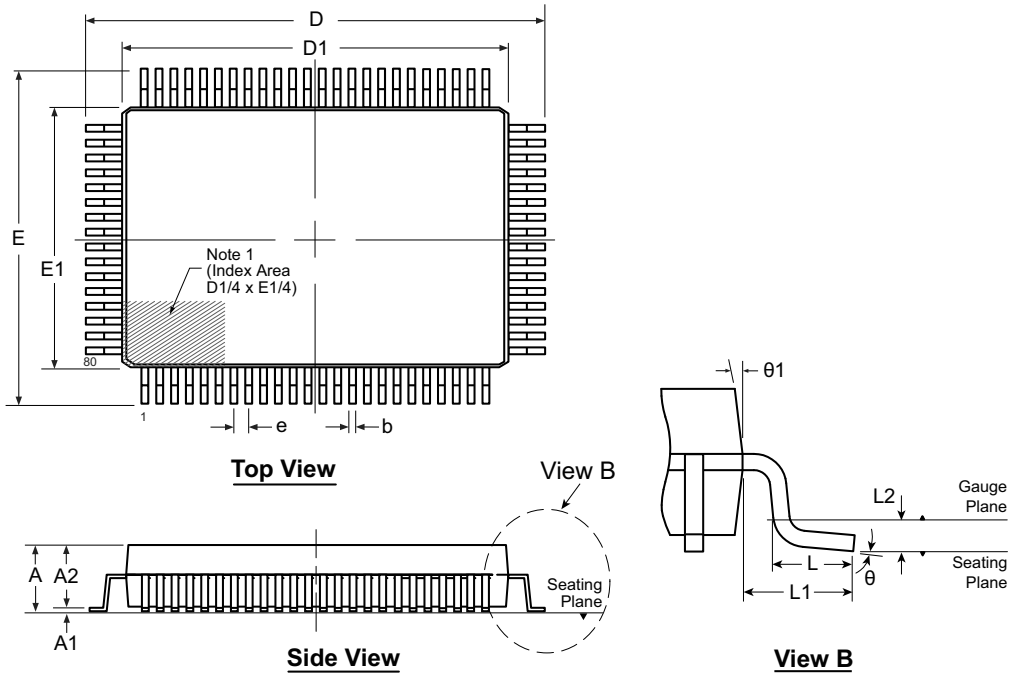
4.1 Packaging Information



Legend:	XX...X	Product Code or Customer-specific information
	Y	Year code (last digit of calendar year)
	YY	Year code (last 2 digits of calendar year)
	WW	Week code (week of January 1 is week '01')
	NNN	Alphanumeric traceability code
	e3	Pb-free JEDEC [®] designator for Matte Tin (Sn)
	*	This package is Pb-free. The Pb-free JEDEC designator (e3) can be found on the outer packaging for this package.
Note:	In the event the full Microchip part number cannot be marked on one line, it will be carried over to the next line, thus limiting the number of available characters for product code or customer-specific information. Package may or not include the corporate logo.	

80-Lead PQFP Package Outline (PG)

20.00x14.00mm body, 3.40mm height (max), 0.80mm pitch, 3.90mm footprint



Note: For the most current package drawings, see the Microchip Packaging Specification at www.microchip.com/packaging.

Note:

1. A Pin 1 identifier must be located in the index area indicated. The Pin 1 identifier can be: a molded mark/identifier; an embedded metal marker; or a printed indicator.

Symbol	A	A1	A2	b	D	D1	E	E1	e	L	L1	L2	θ	$\theta 1$	
Dimension (mm)	MIN	2.80*	0.25	2.55	0.30	23.65*	19.80*	17.65*	13.80*	0.80 BSC	0.73	1.95 REF	0.25 BSC	0°	5°
	NOM	-	-	2.80	-	23.90	20.00	17.90	14.00		0.88			3.5°	-
	MAX	3.40	0.50*	3.05	0.45	24.15*	20.20*	18.15*	14.20*		1.03			7°	16°

JEDEC Registration MO-112, Variation CB-1, Issue B, Sept. 1995.

* This dimension is not specified in the JEDEC drawing.

Drawings not to scale.

HV57009

NOTES:

APPENDIX A: REVISION HISTORY

Revision A (April 2018)

- Converted Supertex Doc # DSFP-HV57009 to Microchip DS20005856A
- Removed “HVCMOS[®] Technology” in the Features section
- Changed the package marking format
- Made minor changes throughout the document

HV57009

PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, contact your local Microchip representative or sales office.

<u>PART NO.</u>	<u>XX</u>	-	<u>X</u>	-	<u>X</u>
Device	Package Options		Environmental		Media Type
Device:	HV57009	=	64-Channel Serial-to-Parallel Converter with P-Channel Open Drain Controllable Output Current		
Package:	PG	=	80-lead PQFP		
Environmental:	G	=	Lead (Pb)-free/RoHS-compliant Package		
Media Type:	(blank)	=	66/Tray for a PG Package		

Example:

a) HV57009PG-G: 64-Channel Serial-to-Parallel Converter with P-Channel Open Drain Controllable Output Current, 80-lead PQFP, 66/Tray

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